

**Search Notes**

Application/Control No.

10/710,288

Examiner

Cong-Lac Huynh

Applicant(s)/Patent under  
Reexamination

BEYER ET AL.

Art Unit

2178

**SEARCHED**

Class	Subclass	Date	Examiner
715	500	12/5/2006	CLH
	513	12/5/2006	CLH
	514	12/5/2006	CLH
707	1, 3	12/7/2006	CLH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	12/5/2006	CLH
ACM	12/5/2006	CLH